

Notice of References CitedApplication/Control No.
09/745,785Applicant(s)/Patent Under
Reexamination
LEUTHOLD ET AL.Examiner
Hanh PhanArt Unit
2633

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,229,633	05-2001	Roberts et al.	398/9
	B	US-6,515,793	02-2003	Edagawa et al.	359/326
	C	US-6,532,091	03-2003	Miyazaki et al.	398/175
	D	US-6,608,854	08-2003	Watanabe, Shigeki	372/96
	E	US-6,108,125	08-2000	Yano, Yutaka	359/344
	F	US- 6,437,905	08-2002	Toyner et al.	359/332
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	PUB. No.: US 2002/0080469 A1 (Leuthold), 27 June 2002 .
	V	
	W	
	X	

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